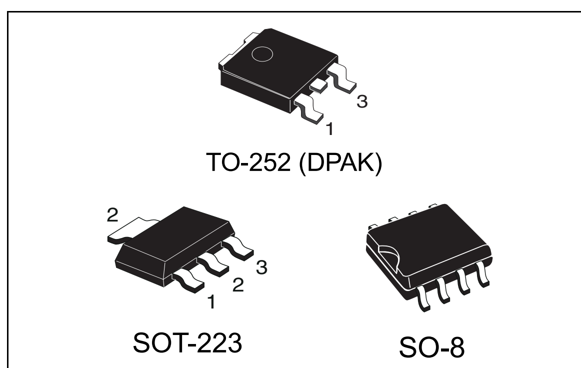
VND1NV04
VNN1NV04 - VNS1NV04

OMNIFET II
fully autoprotected Power MOSFET

Features

Parameter	Symbol	Value
Max on-state resistance (per ch.)	R_{ON}	250 mΩ
Current limitation (typ)	I_{LIMH}	1.7 A
Drain-source clamp voltage	V_{CLAMP}	40 V

- Linear current limitation
- Thermal shutdown
- Short circuit protection
- Integrated clamp
- Low current drawn from input pin
- Diagnostic feedback through input pin
- ESD protection
- Direct access to the gate of the Power MOSFET (analog driving)
- Compatible with standard Power MOSFET



Description

The VND1NV04, VNN1NV04, VNS1NV04 are monolithic devices designed in STMicroelectronics VIPower M0-3 Technology, intended for replacement of standard Power MOSFETs from DC up to 50 KHz applications. Built in thermal shutdown, linear current limitation and overvoltage clamp protect the chip in harsh environments.

Fault feedback can be detected by monitoring the voltage at the input pin.

Table 1. Device summary

Package	Order codes			
	Tube	Tube (lead free)	Tape and reel	Tape and reel (lead free)
TO-252 (DPAK)	VND1NV04	VND1NV04-E	VND1NV04TR	VND1NV04TR-E
SOT-223	VNN1NV04	-	VNN1NV04TR	-
SO-8	VNS1NV04	-	VNS1NV04TR	-

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1 Block diagram and pin description

Figure 1. Block diagram

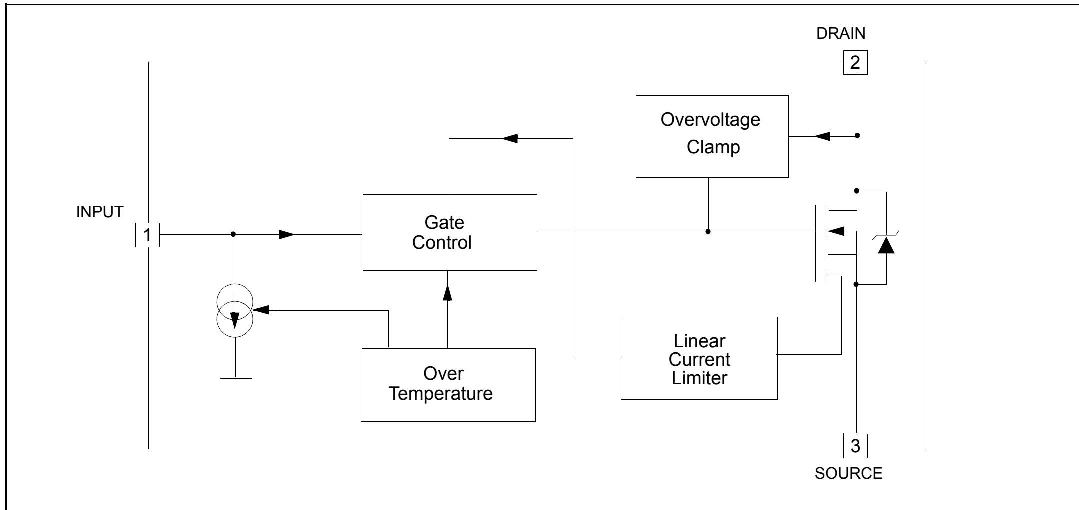
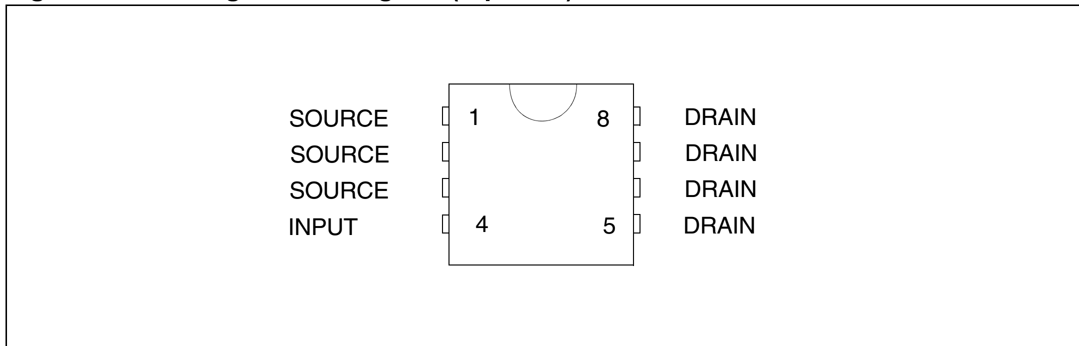


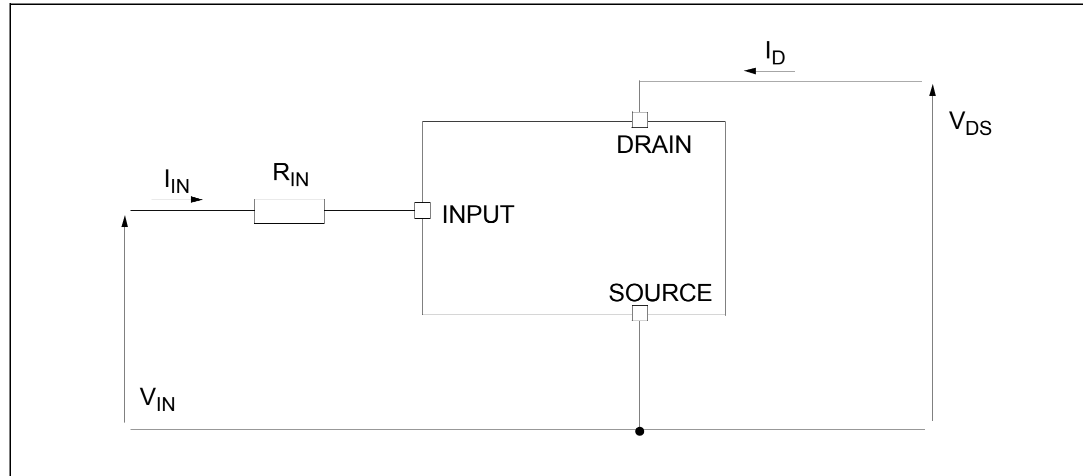
Figure 2. Configuration diagram (top view) [(a)]



a. For the pins configuration related to SOT-223 and DPAK see outline at page 1.

2 Electrical specifications

Figure 3. Current and voltage conventions



2.1 Absolute maximum ratings

Stressing the device above the rating listed in the “Absolute maximum ratings” table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to Absolute maximum rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE program and other relevant quality document.

Table 2. Absolute maximum ratings

Symbol	Parameter	Value			Unit
		SOT-223	SO-8	DPAK	
V_{DSn}	Drain-source voltage (V_{INn}=0 V)	Internally clamped			V
V_{INn}	Input voltage	Internally clamped			V
I_{INn}	Input current	+/-20			mA
$R_{IN\ MINn}$	Minimum input series impedance	330			Ω
I_{Dn}	Drain current	Internally limited			A
I_{Rn}	Reverse DC output current	-3			A
V_{ESD1}	Electrostatic discharge (R=1.5 KΩ, C=100 pF)	4000			V
V_{ESD2}	Electrostatic discharge on output pins only (R=330 Ω, C=150 pF)	16500			V
P_{tot}	Total dissipation at T_c=25 °C	7	8.3	35	W
T_j	Operating junction temperature	Internally limited			°C
T_c	Case operating temperature	Internally limited			°C
T_{stg}	Storage temperature	-55 to 150			°C

2.2 Thermal data

Table 3. Thermal data

Symbol	Parameter	Max value			Unit
		SOT-223	SO-8	DPAK	
$R_{thj-case}$	Thermal resistance junction-case	18		3.5	°C/W
$R_{thj-lead}$	Thermal resistance junction-lead		15		°C/W
$R_{thj-amb}$	Thermal resistance junction-ambient	70[(1)]	65[(1)]	54[(1)]	°C/W

1. When mounted on a standard single-sided FR4 board with 50 mm^2 of Cu (at least 35 µm thick) connected to all DRAIN pins

2.3 Electrical characteristics

Table 4. Electrical characteristics

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
Off (-40 °C<Tj<150 °C, unless otherwise specified)						
V_{CLAMP}	Drain-source clamp voltage	V_{IN}=0 V; I_D=0.5 A	40	45	55	V
V_{CLTH}	Drain-source clamp threshold voltage	V_{IN}=0 V; I_D=2 mA	36			V
V_{INTH}	Input threshold voltage	V_{DS}=V_{IN}; I_D=1 mA	0.5		2.5	V
I_{ISS}	Supply current from input pin	V_{DS}=0 V; V_{IN}=5 V		100	150	µA
V_{INCL}	Input-source clamp voltage	I_{IN}=1 mA I_{IN}=-1 mA	6 -1.0	6.8	8 -0.3	V
I_{DSS}	Zero input voltage drain current (V_{IN}=0 V)	V_{DS}=13 V; V_{IN}=0 V; T_j=25 °C V_{DS}=25 V; V_{IN}=0 V			30 75	µA
On (-40 °C<Tj<150 °C, unless otherwise specified)						
$R_{DS(on)}$	Static drain-source on resistance	V_{IN}=5 V; I_D=0.5 A; T_j=25 °C V_{IN}=5 V; I_D=0.5 A			250 500	mΩ
Dynamic (T_j=25 °C, unless otherwise specified)						
g_{fs} [(1)]	Forward transconductance	V_{DD}=13 V; I_D=0.5 A		2		S
C_{OSS}	Output capacitance	V_{DS}=13 V; f=1 MHz; V_{IN}=0 V		90		pF
Switching (T_j=25 °C, unless otherwise specified)						

Table 4. Electrical characteristics (continued)

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$t_{d(on)}$	Turn-on delay time	V_{DD}=15 V; I_D=0.5 A V_{gen}=5 V; $R_{gen}=R_{IN\ MIN}$=330 Ω (see Figure 4)		70	200	ns
t_r	Rise time			170	500	ns
$t_{d(off)}$	Turn-off delay time			350	1000	ns
t_f	Fall time			200	600	ns
$t_{d(on)}$	Turn-on delay time	V_{DD}=15 V; I_D=0.5 A V_{gen}=5 V; R_{gen}=2.2 KΩ (see Figure 4)		0.25	1.0	µs
t_r	Rise time			1.3	4.0	µs
$t_{d(off)}$	Turn-off delay time			1.8	5.5	µs
t_f	Fall time			1.2	4.0	µs
$(dI/dt)_{on}$	Turn-on current slope	V_{DD}=15 V; I_D=1.5 A V_{gen}=5 V; $R_{gen}=R_{IN\ MIN}$=330 Ω		5		A/µs
Q_i	Total input charge	V_{DD}=12 V; I_D=0.5 A; V_{IN}=5 V I_{gen}=2.13 mA (see Figure 7)		5		nC
Source drain diode (T_j=25 °C, unless otherwise specified)						
V_{SD}(1)	Forward on voltage	I_{SD}=0.5 A; V_{IN}=0 V		0.8		V
t_{rr}	Reverse recovery time	I_{SD}=0.5 A; dI/dt=6 A/µs V_{DD}=30 V; L=200 µH (see Figure 5)		205		ns
Q_{rr}	Reverse recovery charge			100		nC
I_{RRM}	Reverse recovery current			0.7		A
Protections (-40 °C<T_j<150 °C, unless otherwise specified)						
I_{lim}	Drain current limit	V_{IN}=5 V; V_{DS}=13 V	1.7		3.5	A
t_{dlim}	Step response current limit	V_{IN}=5 V; V_{DS}=13 V		2.0		µs
T_{jsh}	Over temperature shutdown		150	175	200	°C
T_{jrs}	Over temperature reset		135			°C
I_{gf}	Fault sink current	V_{IN}=5 V; V_{DS}=13 V; $T_j=T_{jsh}$	10	15	20	mA
E_{as}	Single pulse avalanche energy	Starting T_j=25 °C; V_{DD}=24 V V_{IN}=5 V $R_{gen}=R_{IN\ MIN}$=330 Ω; L=50 mH (see Figure 6 and Figure 8)	55			mJ

1. Pulsed: pulse duration = 300 µs, duty cycle 1.5 %

Figure 4. Switching time test circuit for resistive load

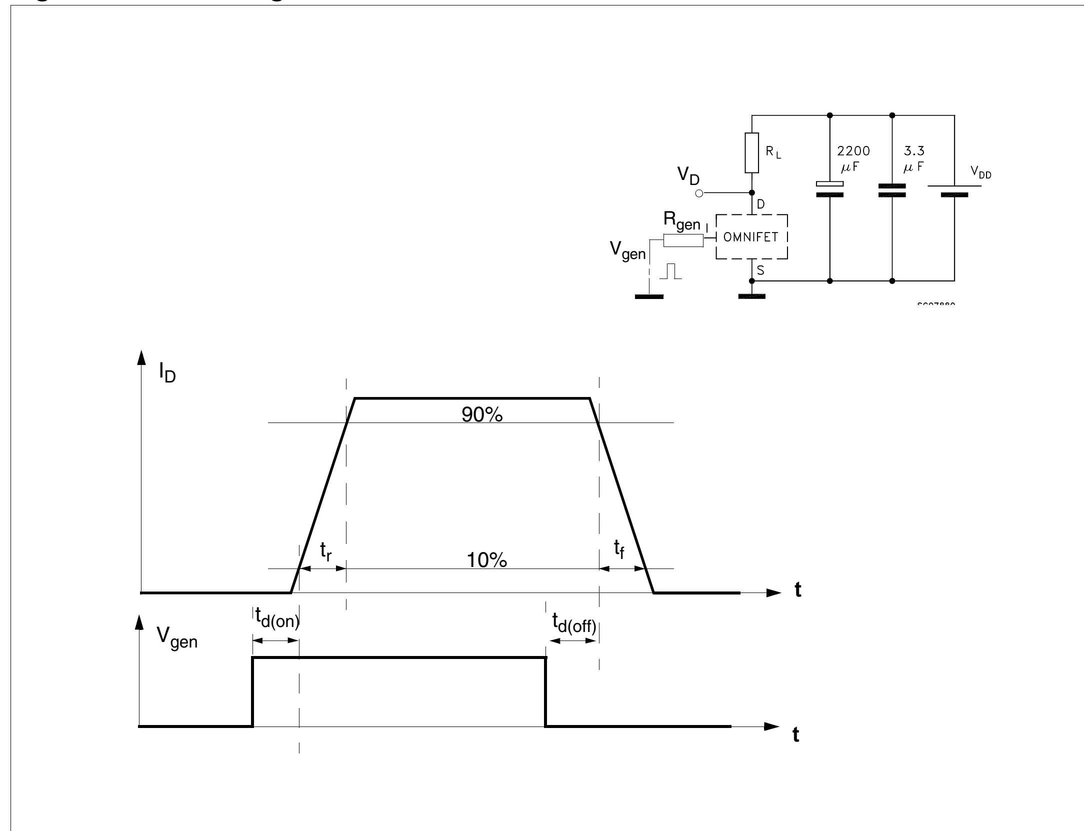


Figure 5. Test circuit for diode recovery times

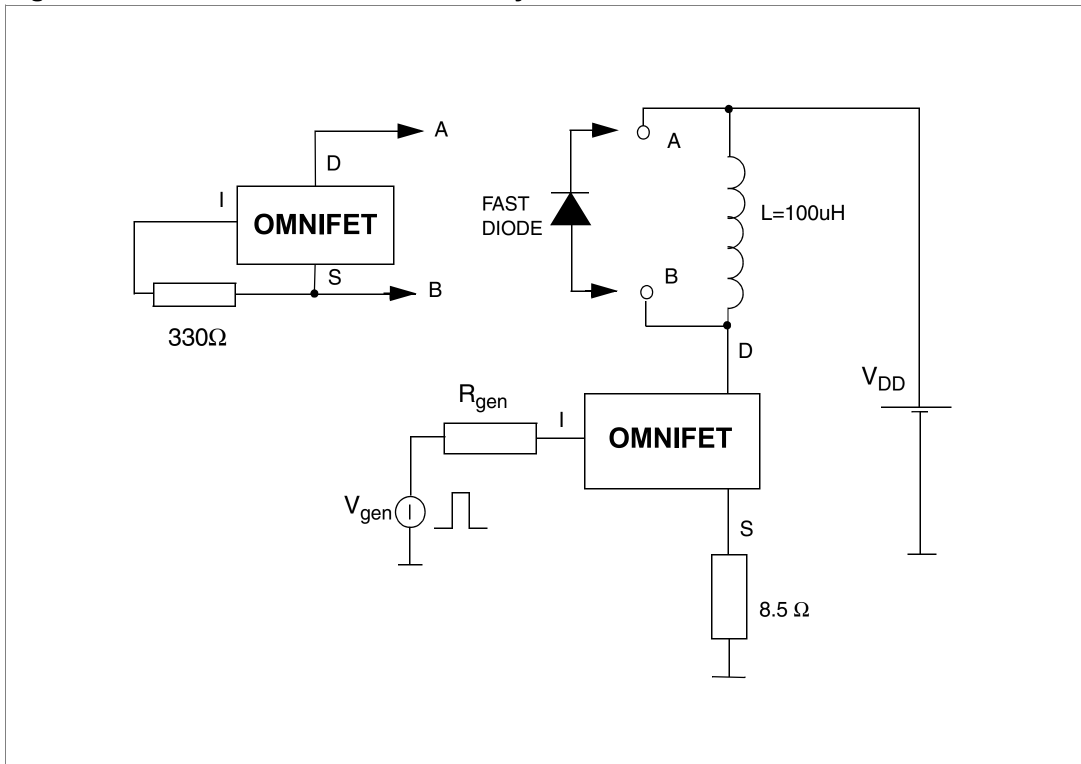


Figure 6. Unclamped inductive load test circuits

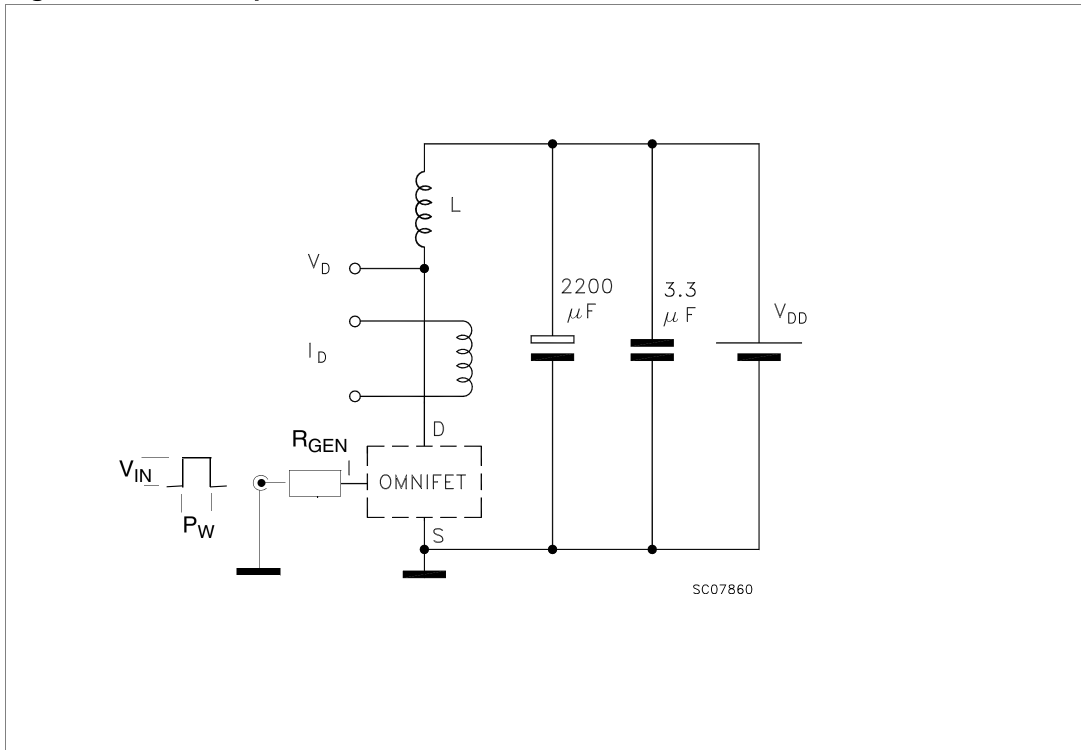


Figure 7. Input charge test circuit

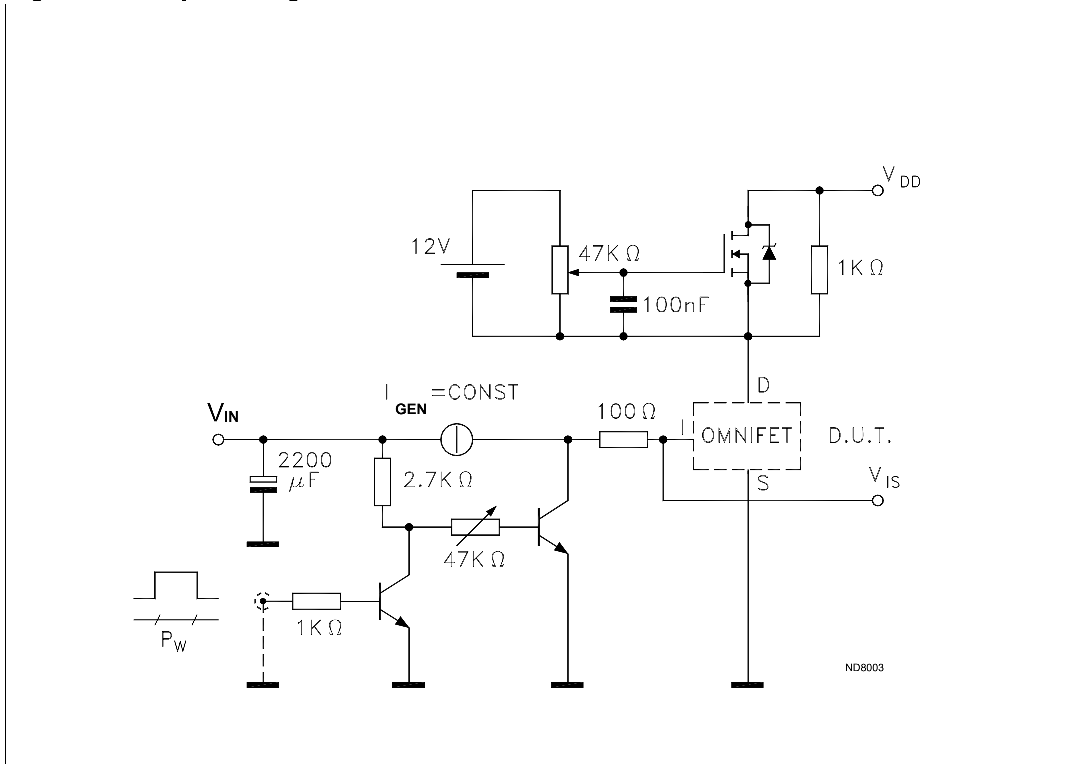
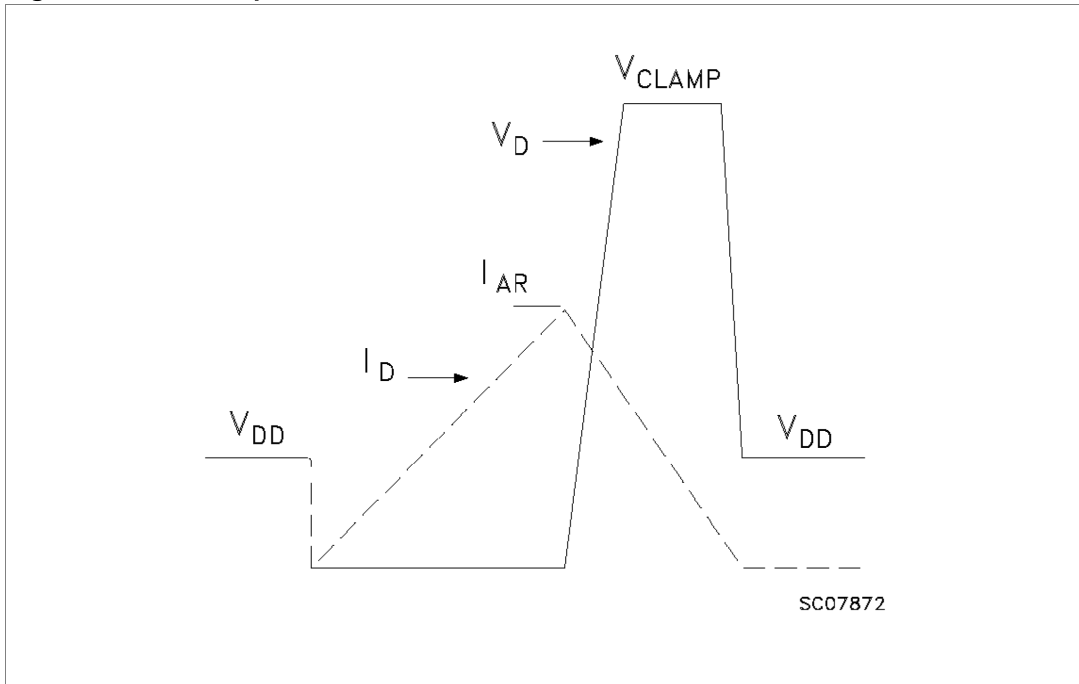


Figure 8. Unclamped inductive waveforms



2.4 Electrical characteristics curves

Figure 9. Source-drain diode forward characteristics

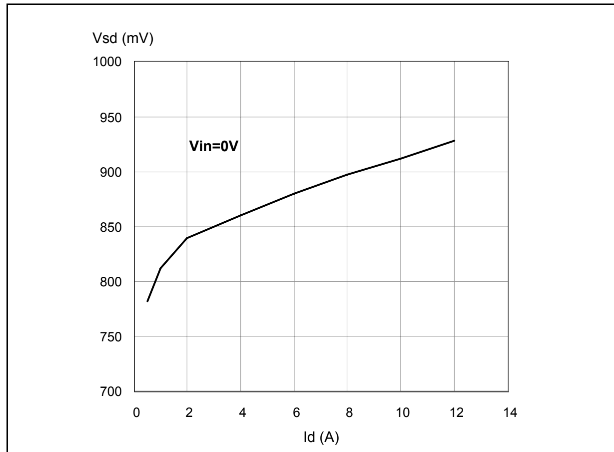


Figure 10. Static drain-source on resistance

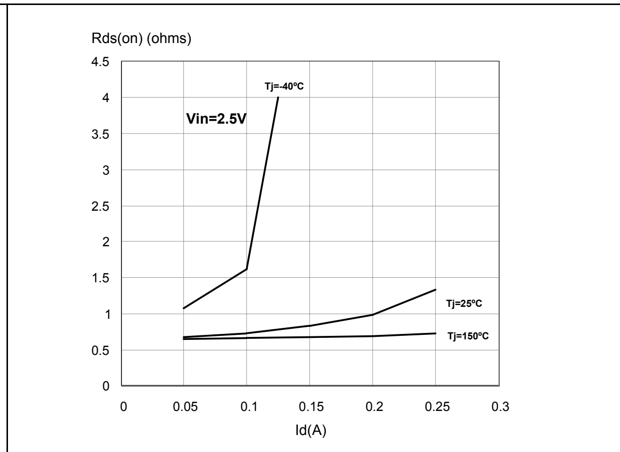


Figure 11. Derating curve

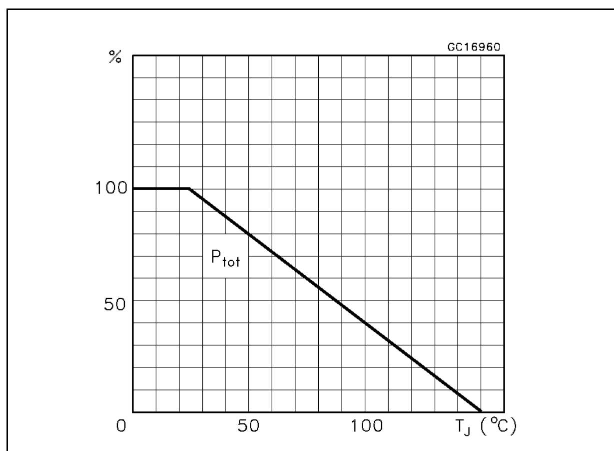


Figure 12. Static drain-source on resistance vs. input voltage (part 1/2)

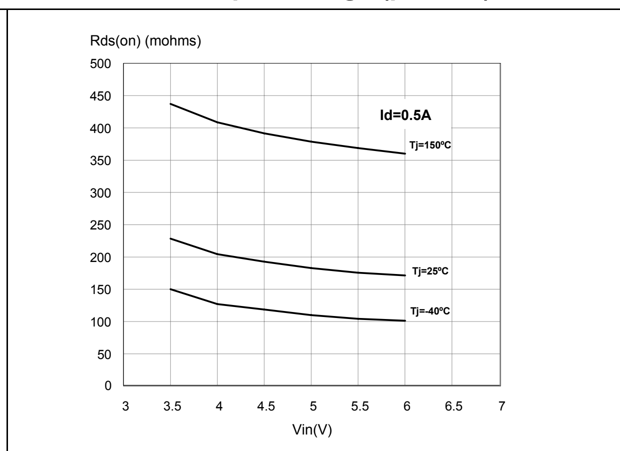


Figure 13. Static drain-source on resistance vs. input voltage (part 2/2)

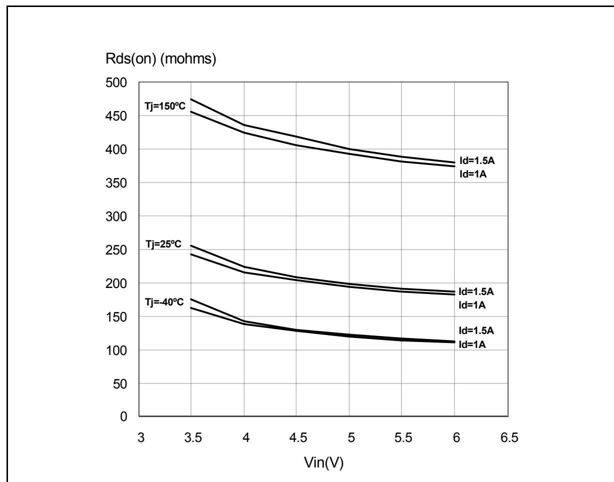


Figure 14. Transconductance

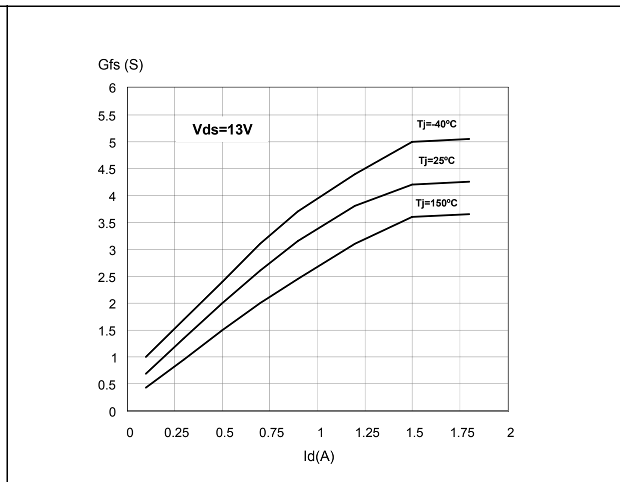


Figure 15. Static drain-source on resistance vs. Id

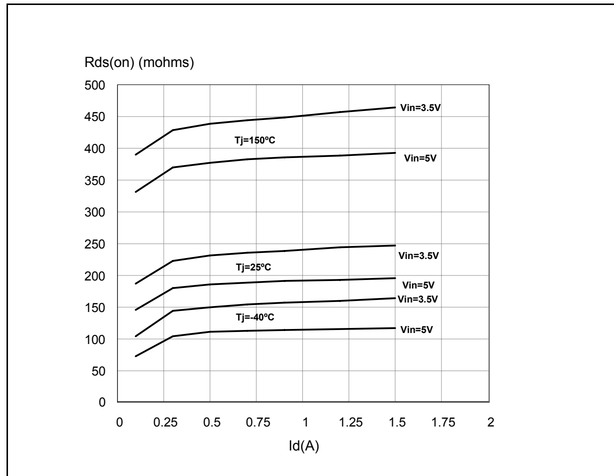


Figure 16. Transfer characteristics

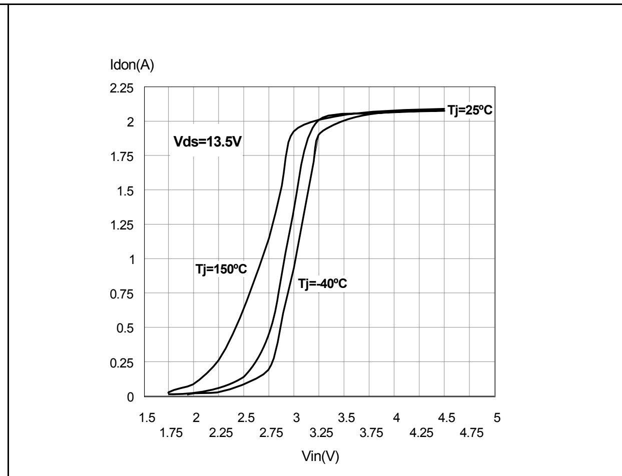


Figure 17. Turn-on current slope (part 1/2)

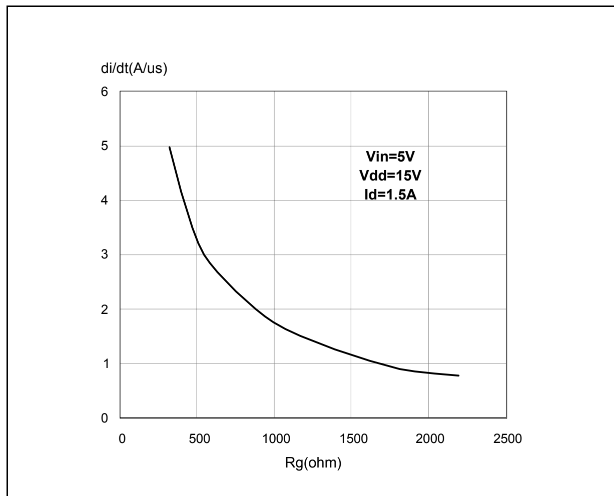


Figure 18. Turn-on current slope (part 2/2)

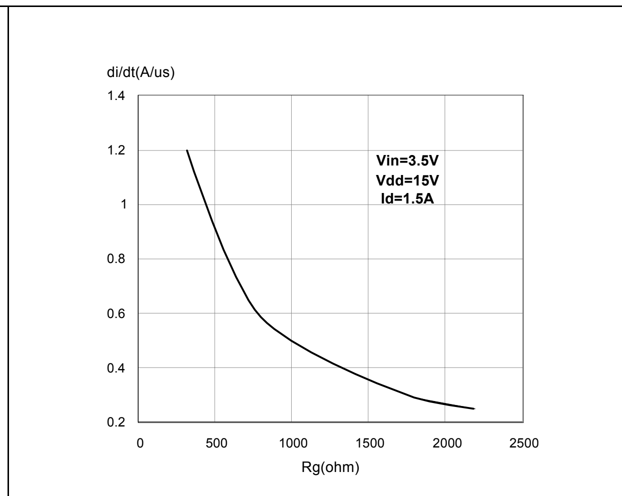


Figure 19. Input voltage vs. input charge

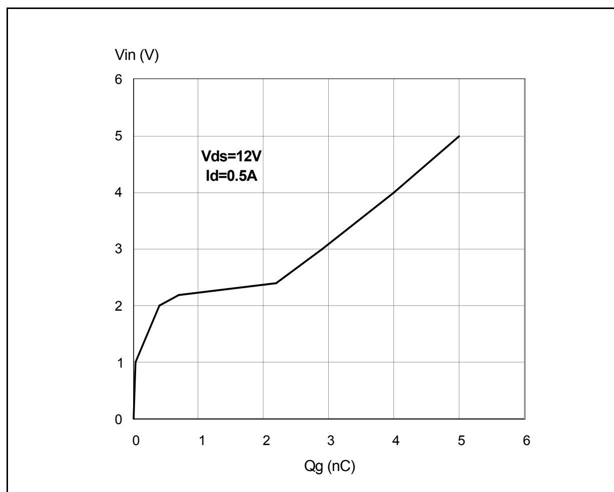


Figure 20. Turn-off drain source voltage slope (part 1/2)

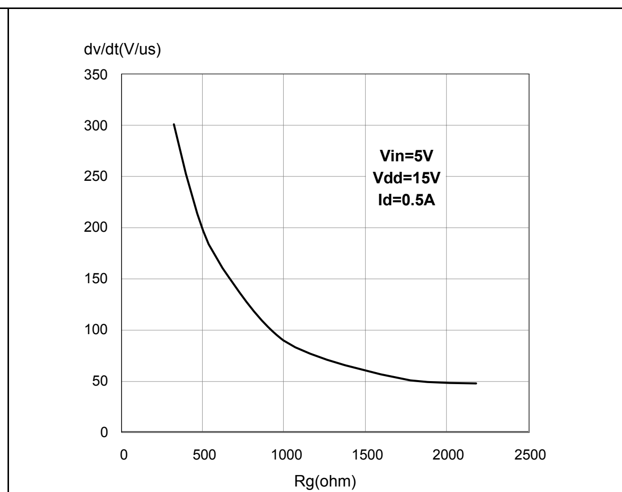


Figure 21. Turn-off drain-source voltage slope (part 2/2)

Figure 22. Capacitance variations

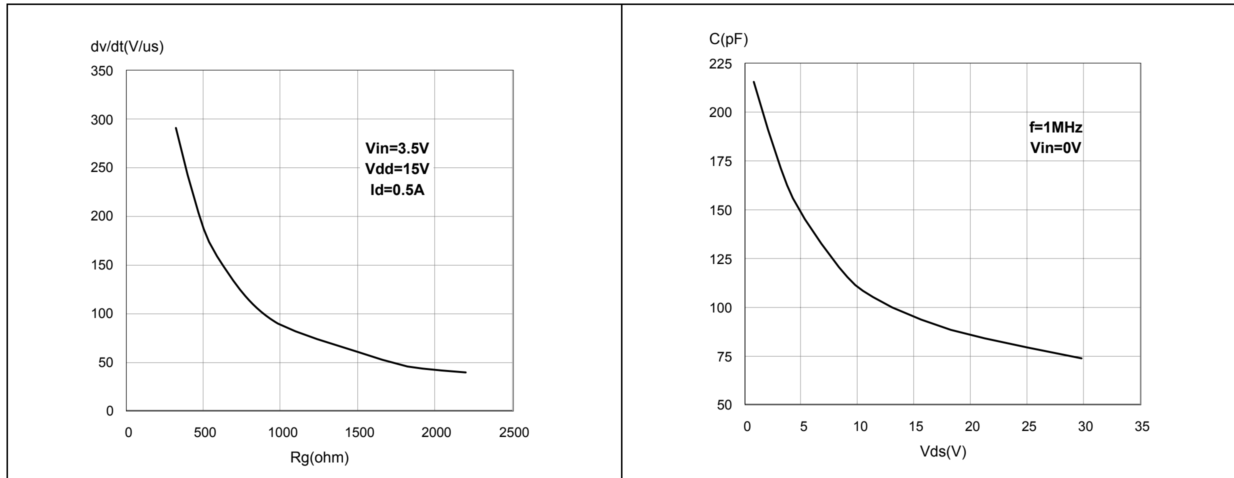


Figure 23. Switching time resistive load (part 1/2)

Figure 24. Switching time resistive load (part 2/2)

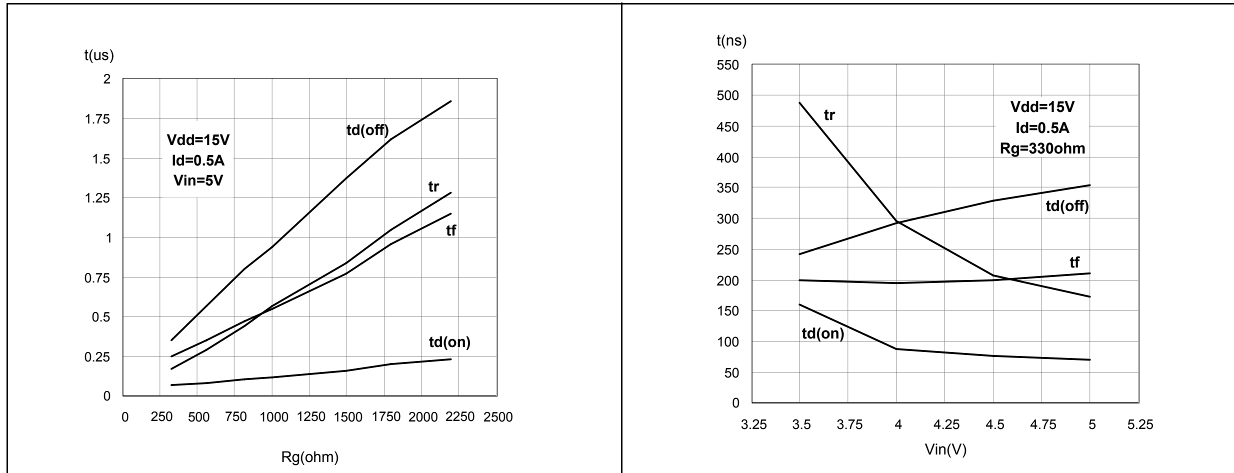


Figure 25. Output characteristics

Figure 26. Normalized on resistance vs. temperature

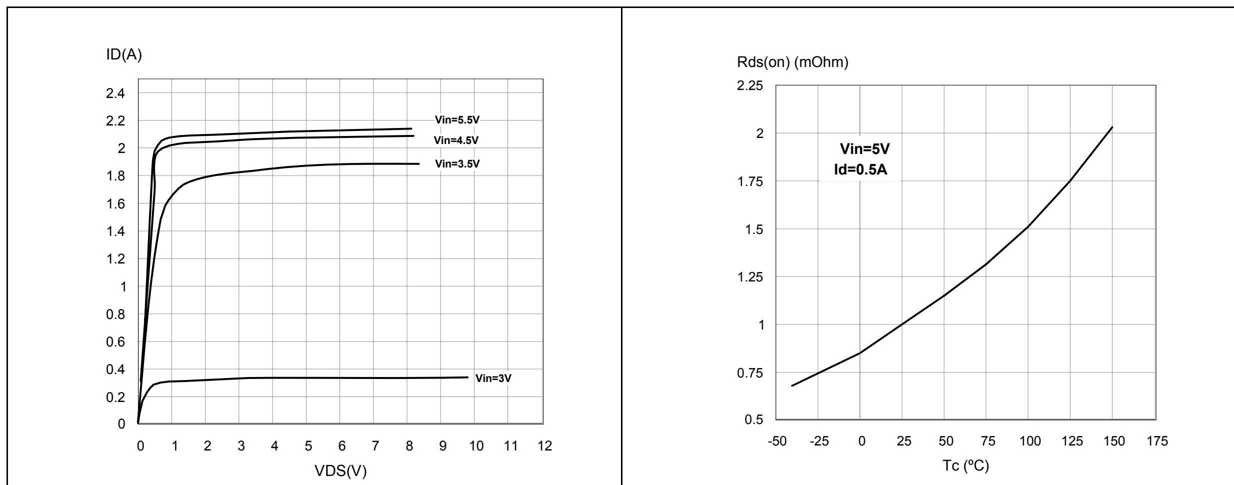


Figure 27. Normalized input threshold voltage vs. temperature

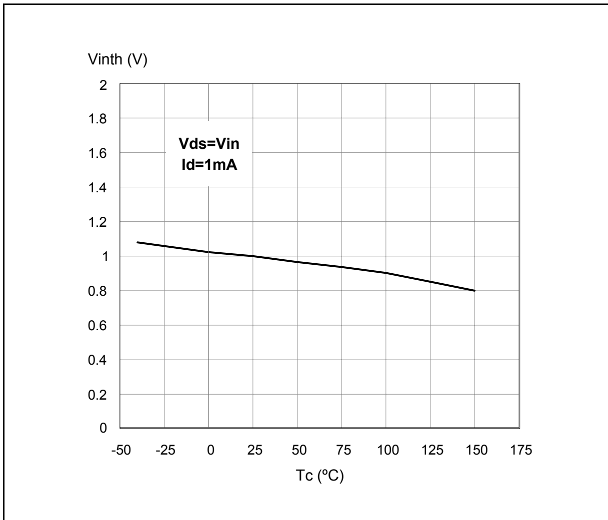


Figure 28. Normalized current limit vs. junction temperature

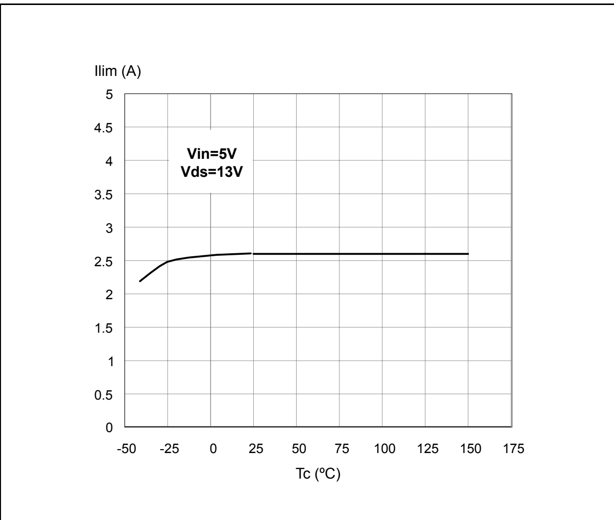
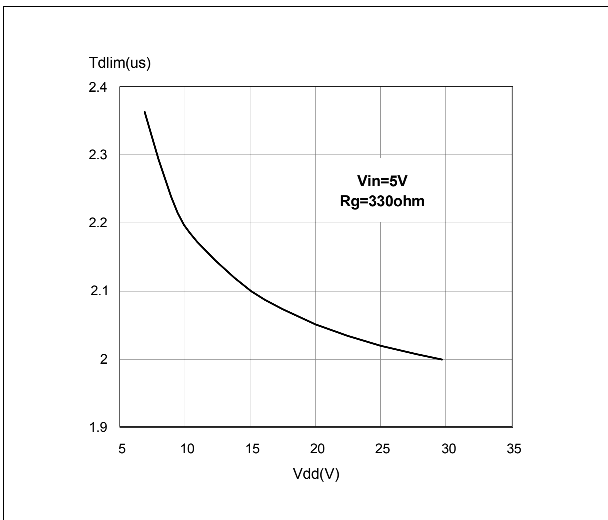


Figure 29. Step response current limit



3 Protection features

During normal operation, the input pin is electrically connected to the gate of the internal Power MOSFET through a low impedance path.

The device then behaves like a standard Power MOSFET and can be used as a switch from DC up to 50 KHz. The only difference from the user's standpoint is that a small DC current I_{ISS} (typ. 100 µA) flows into the input pin in order to supply the internal circuitry.

The device integrates:

3.1 Overvoltage clamp protection

Internally set at 45 V, along with the rugged avalanche characteristics of the Power MOSFET stage give this device unrivalled ruggedness and energy handling capability. This feature is mainly important when driving inductive loads.

3.2 Linear current limiter circuit

Limits the drain current I_D to I_{lim} whatever the input pin voltages. When the current limiter is active, the device operates in the linear region, so power dissipation may exceed the capability of the heatsink. Both case and junction temperatures increase, and if this phase lasts long enough, junction temperature may reach the over temperature threshold $T_{jsh.}$

3.3 Over temperature and short circuit protection

These are based on sensing the chip temperature and are not dependent on the input voltage. The location of the sensing element on the chip in the power stage area ensures fast, accurate detection of the junction temperature. Over temperature cutout occurs in the range 150 to 190 °C, a typical value being 170 °C. The device is automatically restarted when the chip temperature falls of about 15 °C below shutdown temperature.

3.4 Status feedback

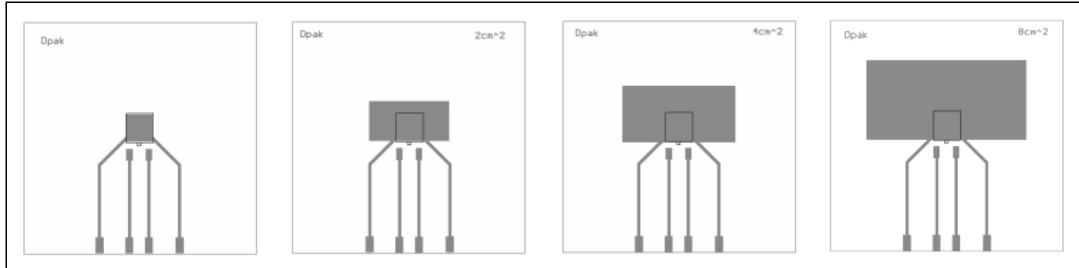
In the case of an over temperature fault condition ($T_j > T_{jsh}$), the device tries to sink a diagnostic current I_{gf} through the input pin in order to indicate fault condition. If driven from a low impedance source, this current may be used in order to warn the control circuit of a device shutdown. If the drive impedance is high enough so that the input pin driver is not able to supply the current I_{gf}, the input pin will fall to 0 V. This will not however affect the device operation: no requirement is put on the current capability of the input pin driver except to be able to supply the normal operation drive current I_{ISS}.

Additional features of this device are ESD protection according to the Human Body model and the ability to be driven from a TTL logic circuit.

4 Package and PCB thermal data

4.1 DPAK thermal data

Figure 30. DPAK PC board



1. Layout condition of R_{th} and Z_{th} measurements (PCB FR4 area = 58 mm x 58 mm,PCB thickness = 2 mm, Cu thickness=35 µm , Copper areas: from minimum pad layout to 16 cm^2).

Figure 31. DPAK $R_{thj-amb}$ vs. PCB copper area in open box free air condition

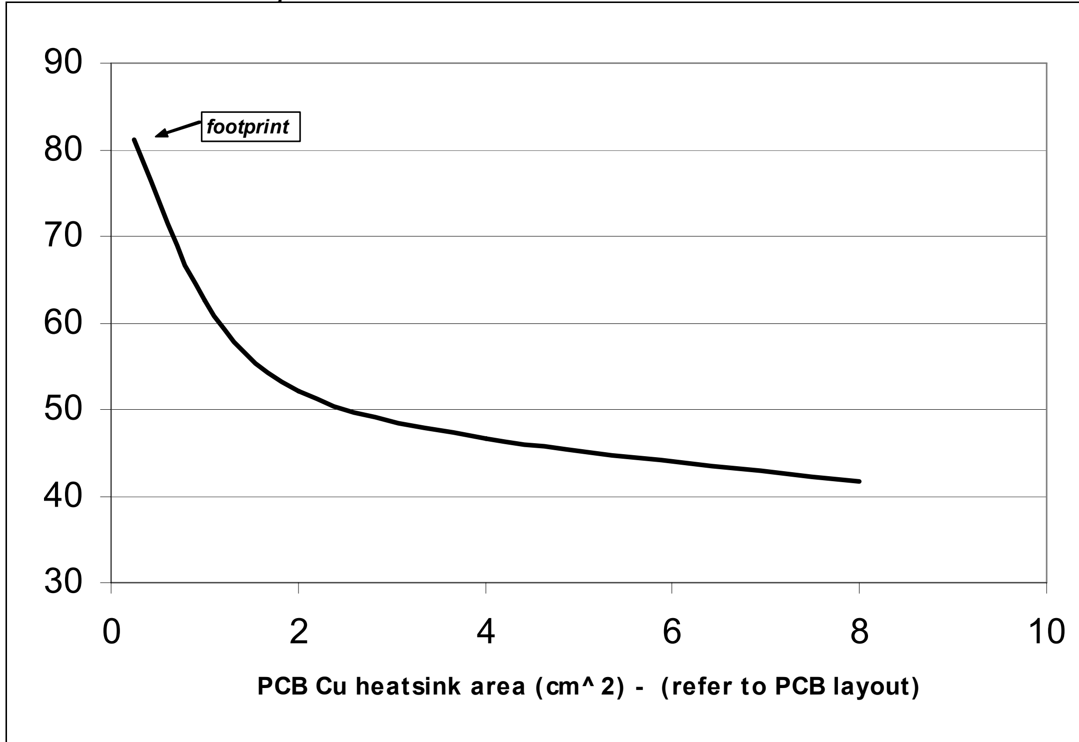
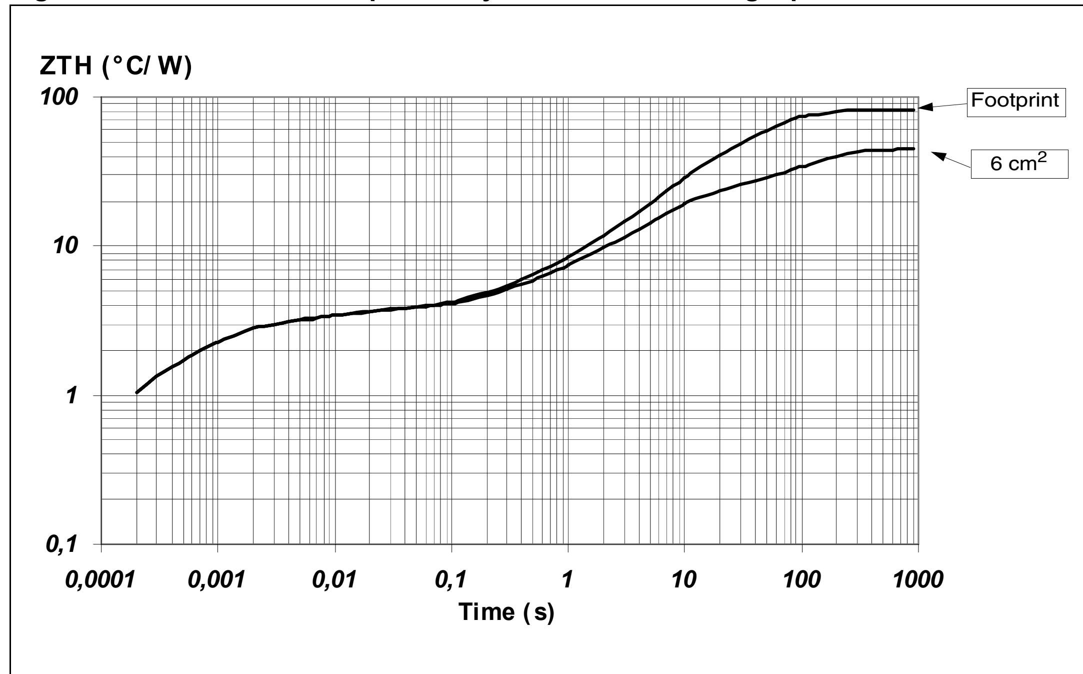


Figure 32. DPAK thermal impedance junction ambient single pulse



Equation 1: pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

where $\delta = t_P/T$

Figure 33. DPAK thermal fitting model of a single channel

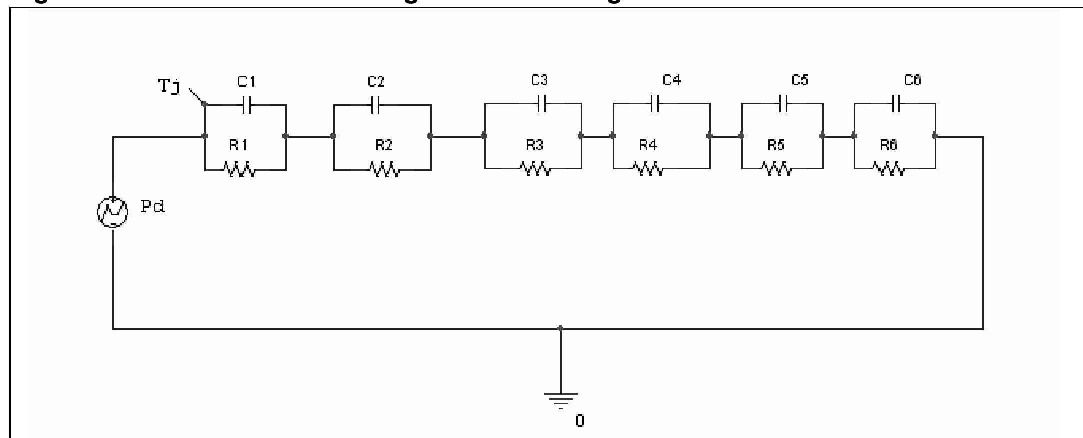
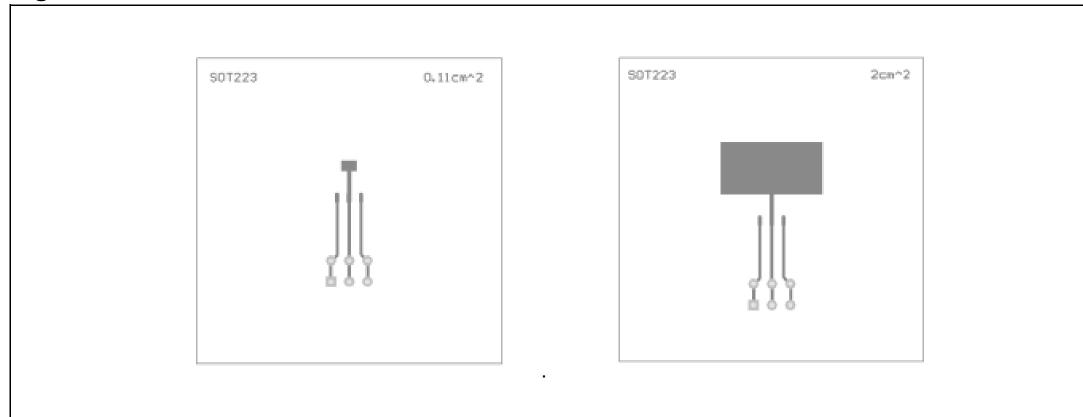


Table 5. DPAK thermal parameter

Area/island (cm^2)	0.25	6
R1 (°C/W)	0.8	
R2 (°C/W)	1.6	
R3 (°C/W)	0.8	
R4 (°C/W)	2	
R5 (°C/W)	15	
R6 (°C/W)	61	24
C1 (W·s/°C)	0.00006	
C2 (W·s/°C)	0.0005	
C3 (W·s/°C)	0.01	
C4 (W·s/°C)	0.3	
C5 (W·s/°C)	0.45	
C6 (W·s/°C)	0.8	5

4.2 SOT-223 thermal data

Figure 34. SOT-223 PC board



1. Layout condition of R_{th} and Z_{th} measurements (PCB FR4 area = 58 mm x 58 mm,PCB thickness = 2 mm, Cu thickness=35 µm , Copper areas: from minimum pad layout to 0.8 cm^2).

Figure 35. SOT-223 $R_{thj-amb}$ vs. PCB copper area in open box free air condition

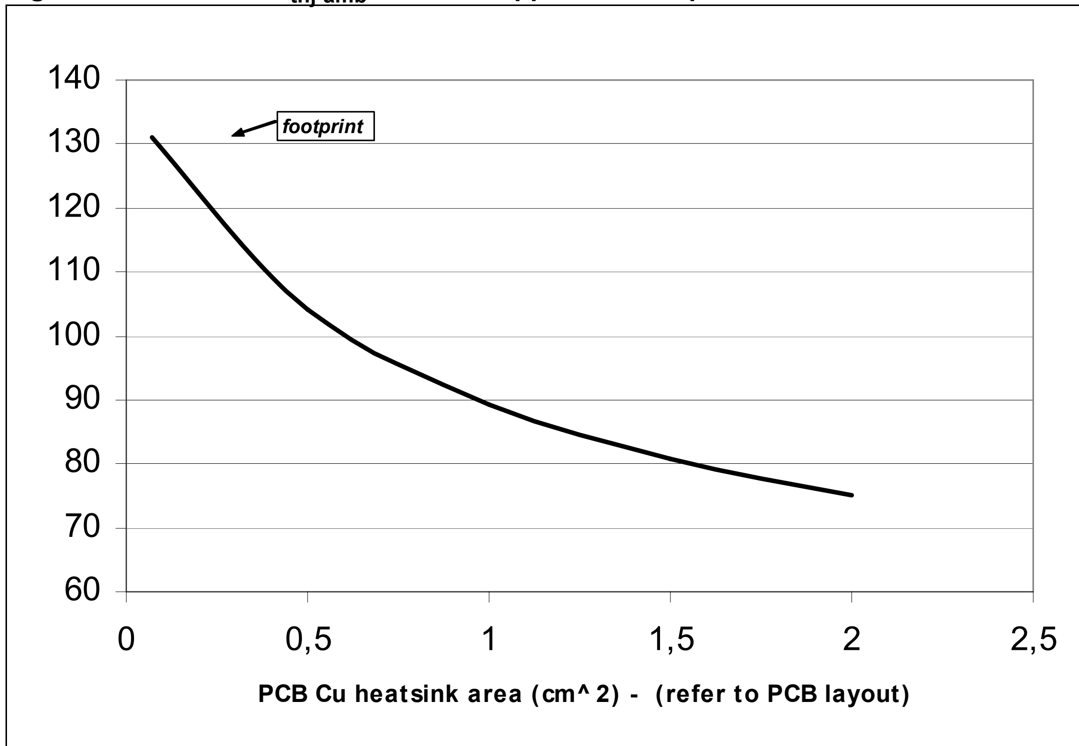
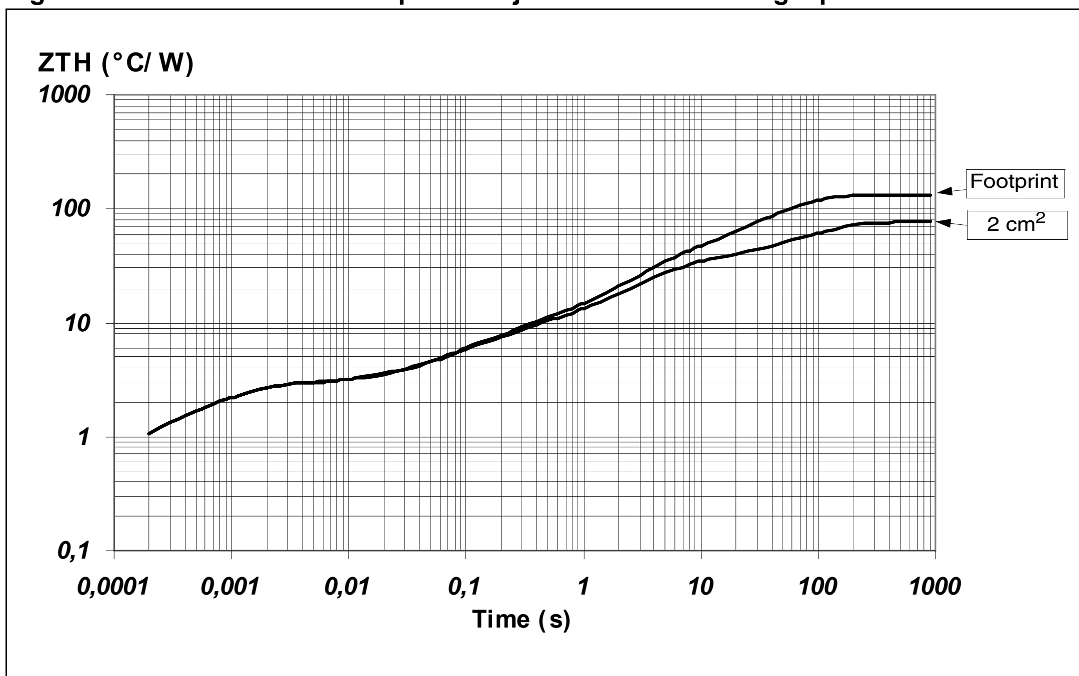


Figure 36. SOT-223 thermal impedance junction ambient single pulse



Equation 2: pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

where $\delta = t_P/T$

Figure 37. SOT-223 thermal fitting model of a single channel

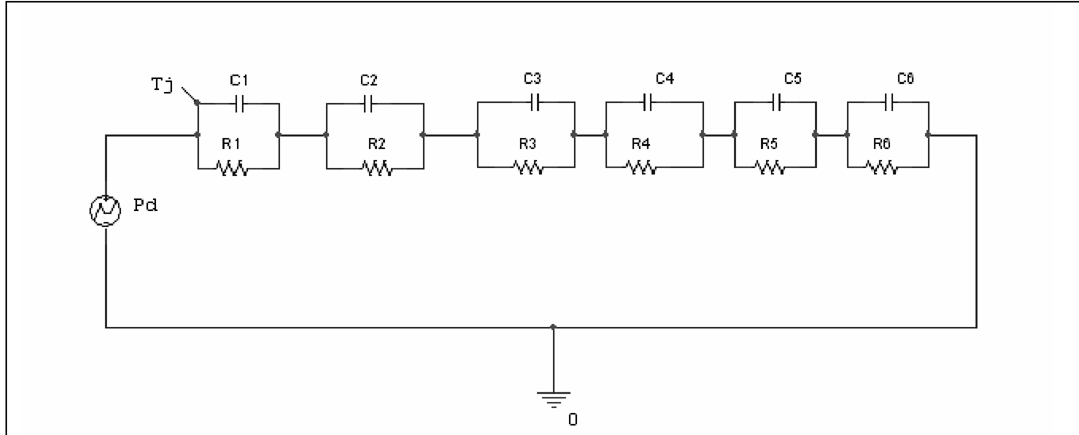
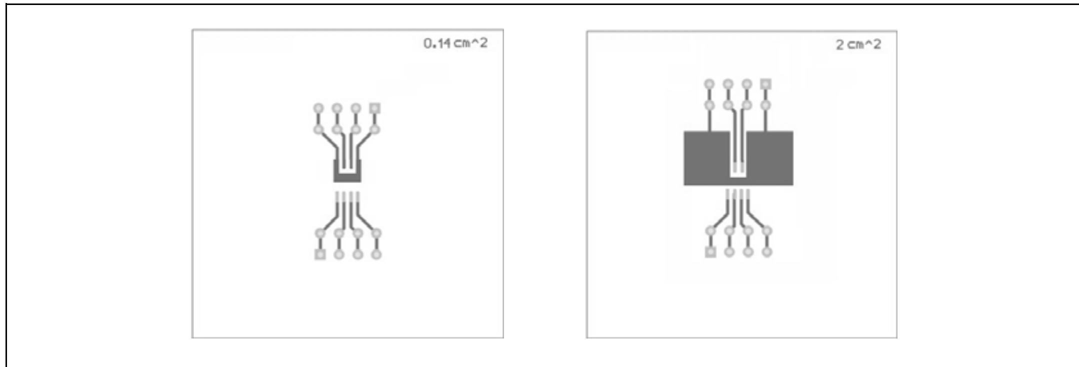


Table 6. SOT-223 thermal parameter

Area/island (cm^2)	FP	2
R1 (°C/W)	0.8	
R2 (°C/W)	1.6	
R3 (°C/W)	4.5	
R4 (°C/W)	24	
R5 (°C/W)	0.1	
R6 (°C/W)	100	45
C1 (W·s/°C)	0.00006	
C2 (W·s/°C)	0.0005	
C3 (W·s/°C)	0.03	
C4 (W·s/°C)	0.16	
C5 (W·s/°C)	1000	
C6 (W·s/°C)	0.5	2

4.3 SO-8 thermal data

Figure 38. SO-8 PC board



1. Layout condition of R_{th} and Z_{th} measurements (PCB FR4 area = 58 mm x 58 mm,PCB thickness = 2 mm, Cu thickness=35 µm , Copper areas: from minimum pad layout to 2 cm^2).

Figure 39. SO-8 $R_{thj\text{-}amb}$ vs. PCB copper area in open box free air condition

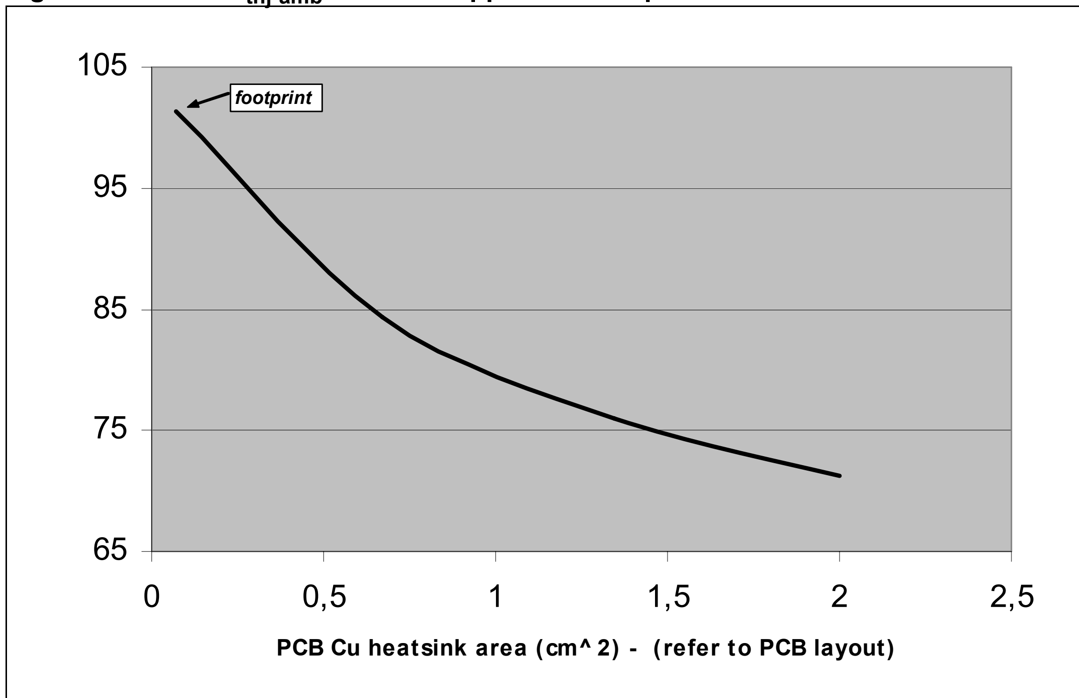
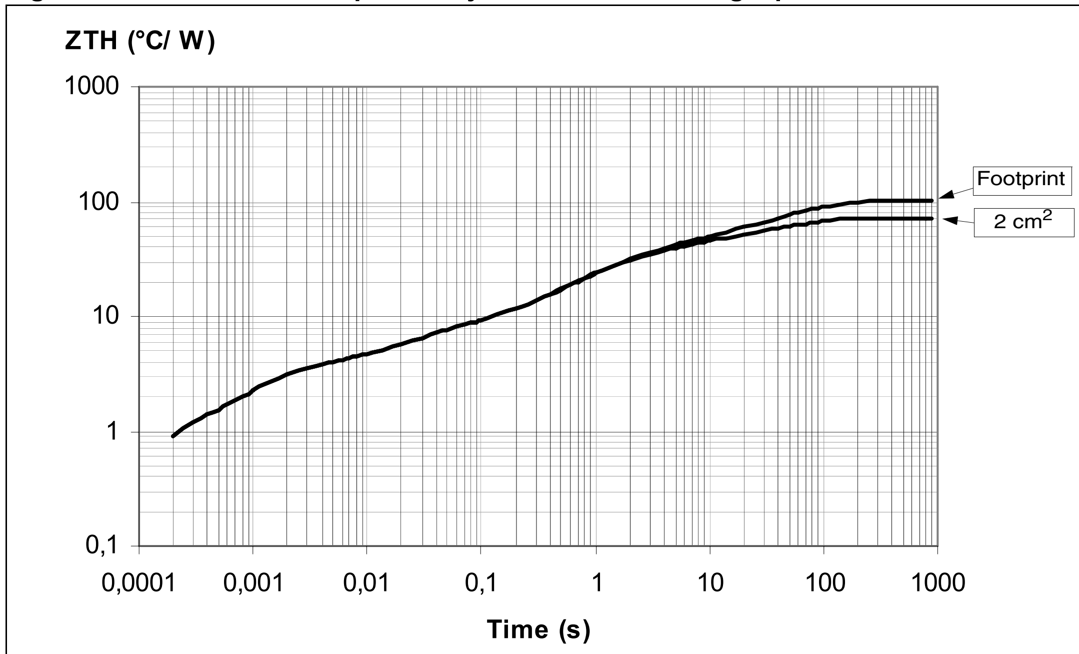


Figure 40. SO-8 thermal impedance junction ambient single pulse



Equation 3: pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

where $\delta = t_P/T$

Figure 41. SO-8 thermal fitting model of a single channel

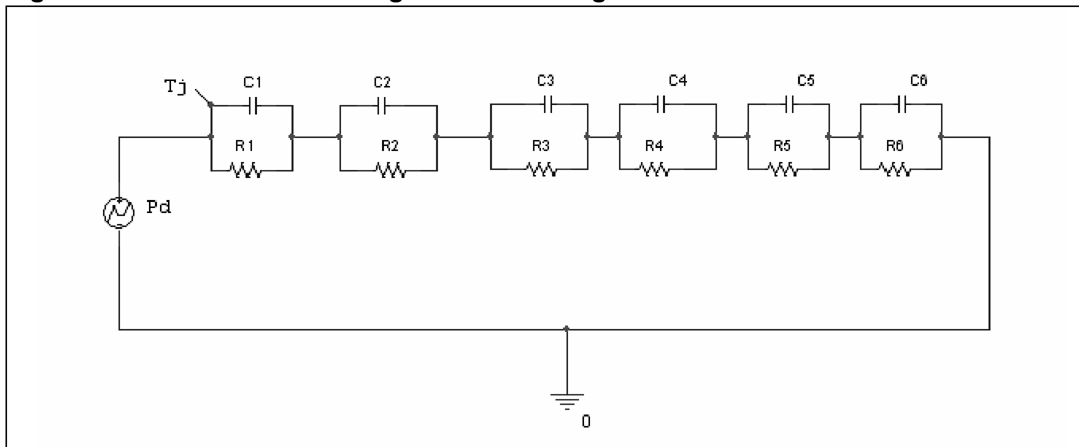


Table 7. SO-8 thermal parameter

Area/island (cm^2)	FP	2
R1 (°C/W)	0.8	
R2 (°C/W)	2.6	
R3 (°C/W)	3.5	
R4 (°C/W)	21	
R5 (°C/W)	16	
R6 (°C/W)	58	28
C1 (W·s/°C)	0.00006	
C2 (W·s/°C)	0.0005	
C3 (W·s/°C)	0.0075	
C4 (W·s/°C)	0.045	
C5 (W·s/°C)	0.35	
C6 (W·s/°C)	1.05	2

5 Package and packing information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com.

ECOPACK® is an ST trademark.

5.1 DPAK mechanical data

Figure 42. DPAK package dimensions

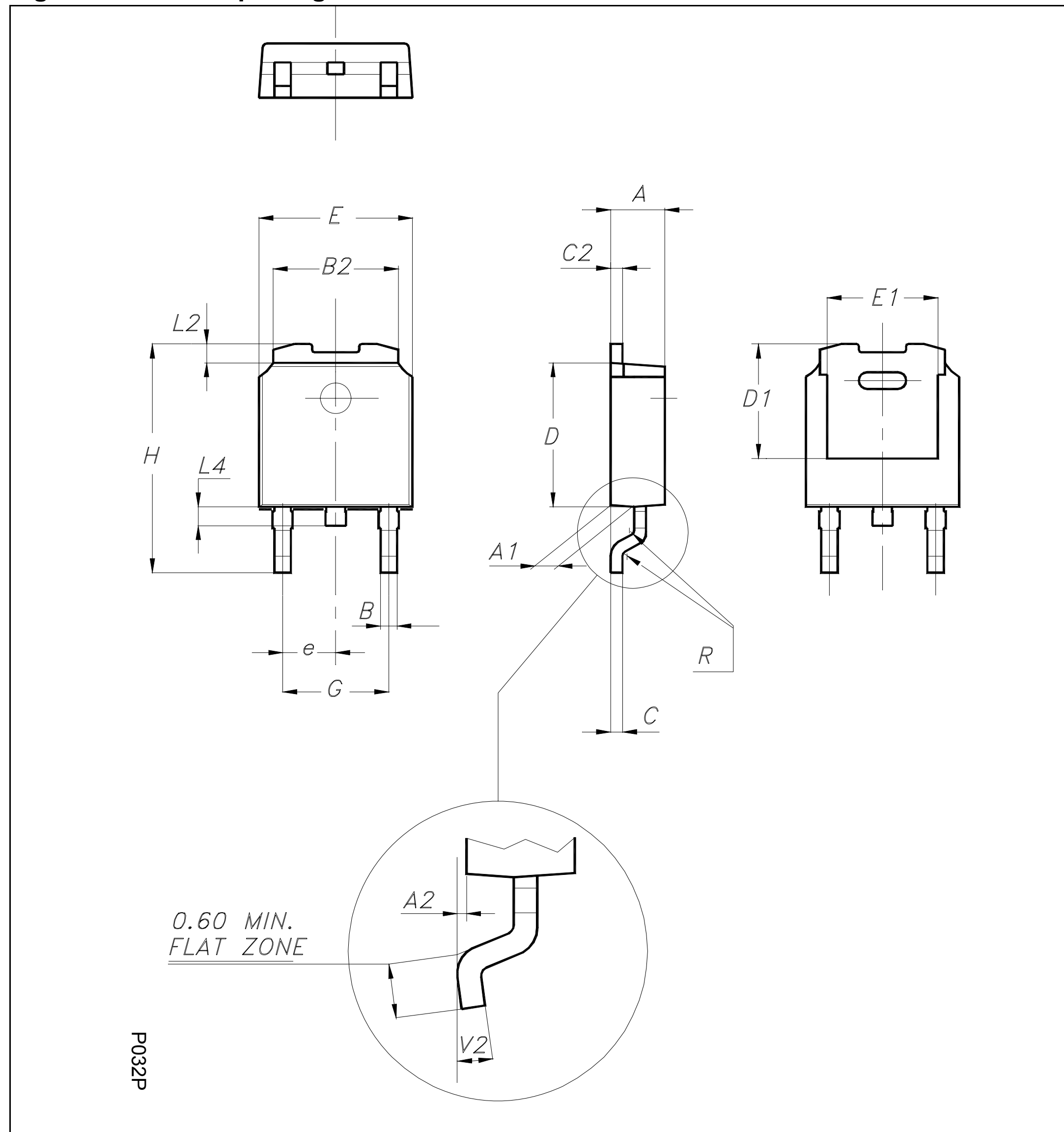
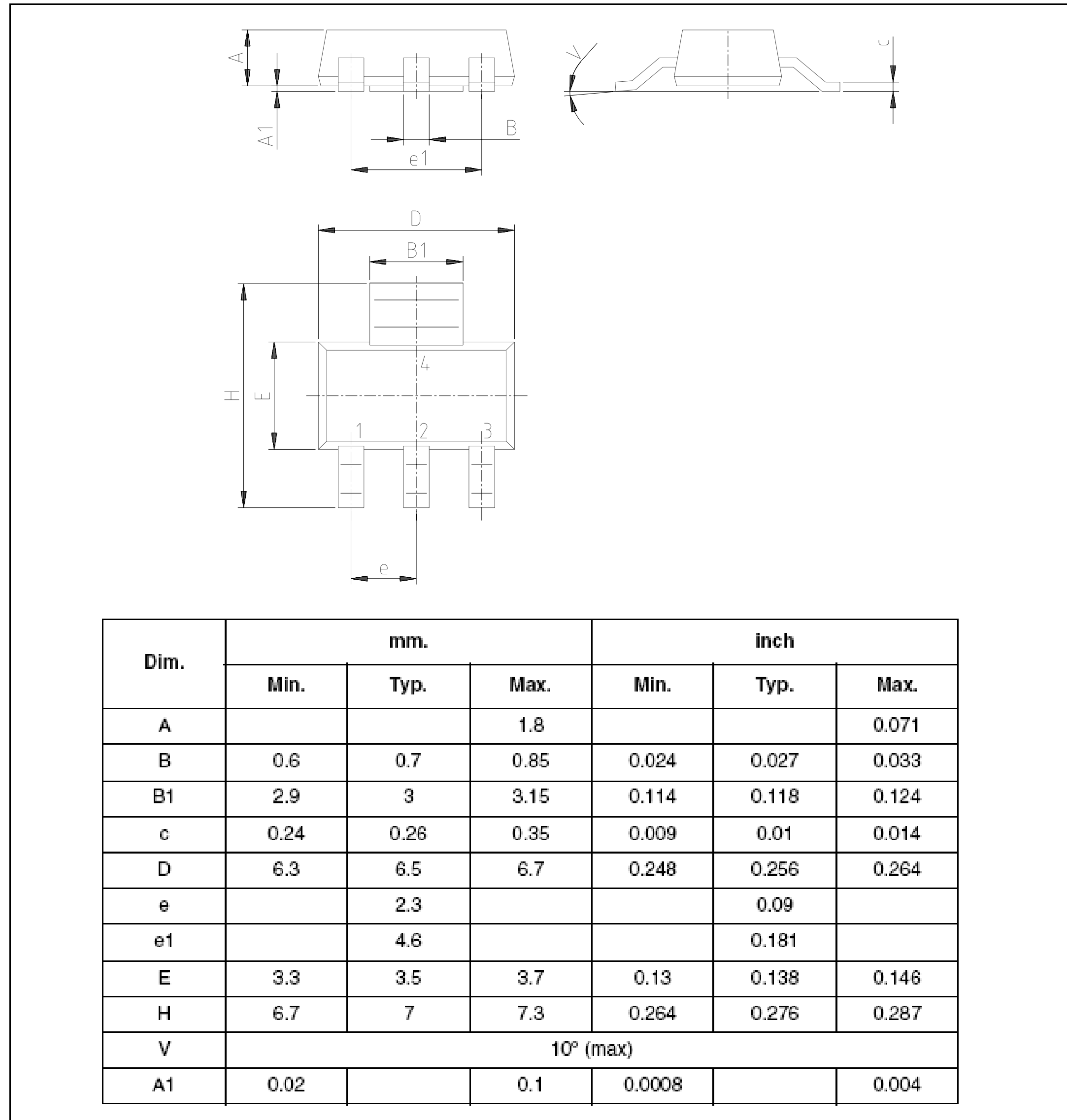


Table 8. DPAK mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
B	0.64		0.90
B2	5.20		5.40
C	0.45		0.60
C2	0.48		0.60
D	6.00		6.20
D1		5.1	
E	6.40		6.60
E1		4.7	
e		2.28	
G	4.40		4.60
H	9.35		10.10
L2		0.8	
L4	0.60		1.00
R		0.2	
V2	0°	8°	
Package weight		Gr. 0.29	

5.2 SOT-223 mechanical data

Figure 43. SOT-223 mechanical data & package outline



Dim.	mm.			inch		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A			1.8			0.071
B	0.6	0.7	0.85	0.024	0.027	0.033
B1	2.9	3	3.15	0.114	0.118	0.124
c	0.24	0.26	0.35	0.009	0.01	0.014
D	6.3	6.5	6.7	0.248	0.256	0.264
e		2.3			0.09	
e1		4.6			0.181	
E	3.3	3.5	3.7	0.13	0.138	0.146
H	6.7	7	7.3	0.264	0.276	0.287
V	10° (max)					
A1	0.02		0.1	0.0008		0.004

5.3 SO8 mechanical data

Table 9. SO-8 mechanical data

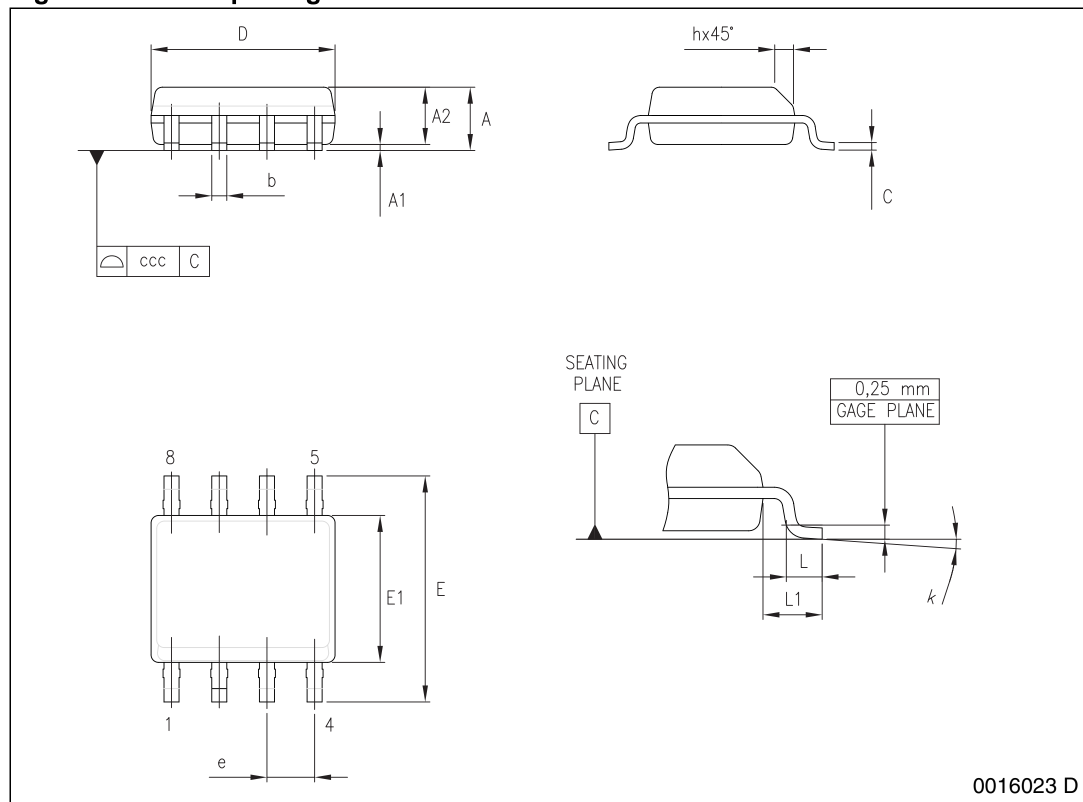
Dim.	mm		
	Min.	Typ.	Max.
A			1.75
A1	0.10		0.25
A2	1.25		

Table 9. SO-8 mechanical data (continued)

Dim.	mm		
	Min.	Typ.	Max.
b	0.28		0.48
c	0.17		0.23
D(1)	4.80	4.90	5.00
E	5.80	6.00	6.20
E1(2)	3.80	3.90	4.00
e		1.27	
h	0.25		0.50
L	0.40		1.27
L1		1.04	
k	0°		8°
ccc			0.10

1. Dimension “D” does not include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.15 mm in total (both side).
2. Dimension “E1” does not include interlead flash or protrusions. Interlead flash or protrusions shall not exceed 0.25 mm per side.

Figure 44. SO-8 package dimension



5.4 DPAK packing information

The devices can be packed in tube or tape and reel shipments (see the *Device summary on page 1*).

DPAK FOOTPRINT

TUBE SHIPMENT (no suffix)

Base Q.ty	75
Bulk Q.ty	3000
Tube length (± 0.5)	532
A	6
B	21.3
C (± 0.1)	0.6

All dimensions are in mm.

TAPE AND REEL SHIPMENT (suffix "13TR")

REEL DIMENSIONS

Base Q.ty	2500
Bulk Q.ty	2500
A (max)	330
B (min)	1.5
C (± 0.2)	13
F	20.2
G (+ 2 / -0)	16.4
N (min)	60
T (max)	22.4

TAPE DIMENSIONS

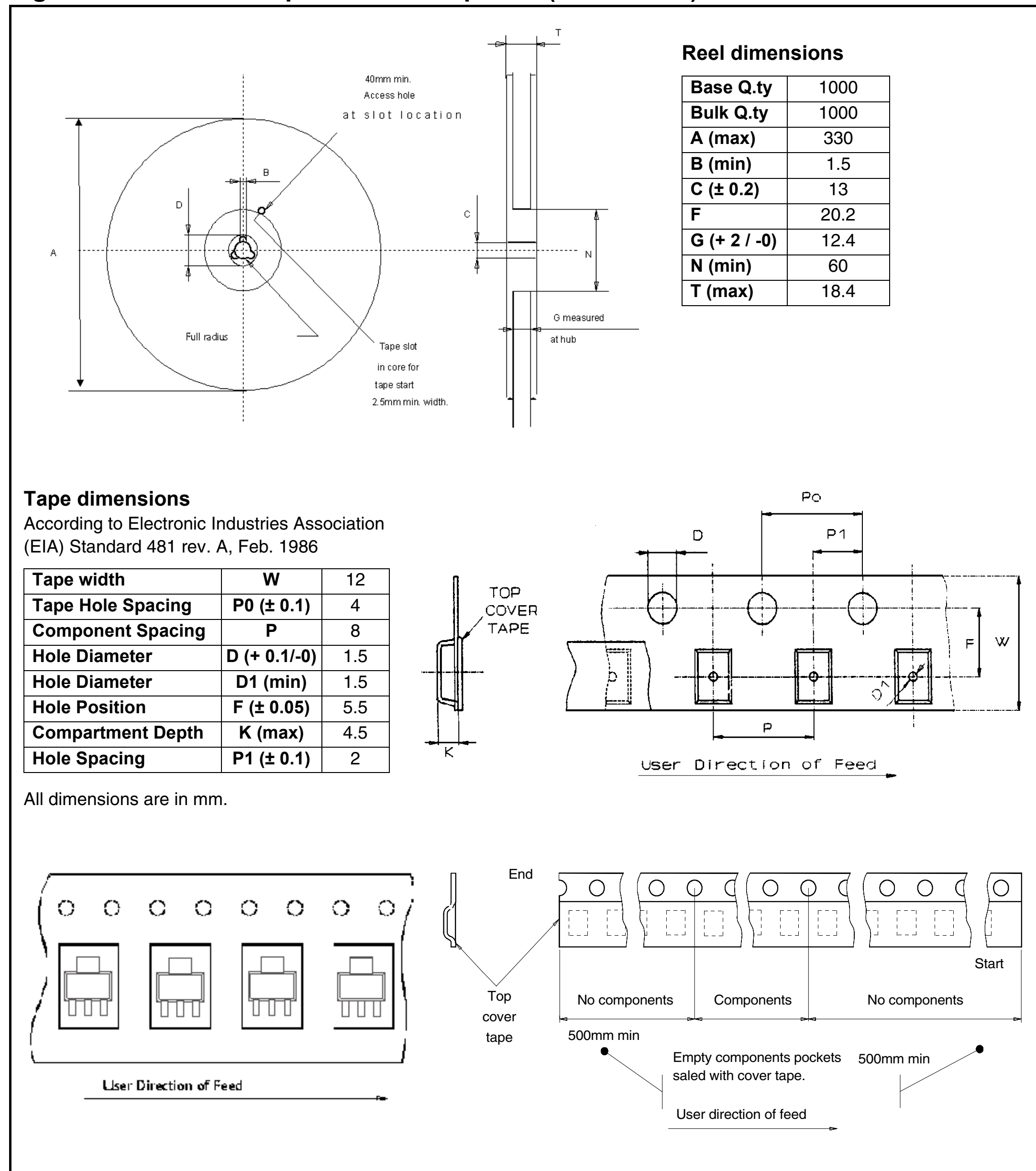
According to Electronic Industries Association (EIA) Standard 481 rev. A, Feb 1986

Tape width	**W**	16
Tape Hole Spacing	**P0 (± 0.1)**	4
Component Spacing	**P**	8
Hole Diameter	**D (± 0.1/-0)**	1.5
Hole Diameter	**D1 (min)**	1.5
Hole Position	**F (± 0.05)**	7.5
Compartment Depth	**K (max)**	6.5
Hole Spacing	**P1 (± 0.1)**	2

All dimensions are in mm.

5.5 SOT-223 packing information

Figure 45. SOT-223 tape and reel shipment (suffix “TR”)



Reel dimensions

Base Q.ty	1000
Bulk Q.ty	1000
A (max)	330
B (min)	1.5
C (± 0.2)	13
F	20.2
G (+ 2 / -0)	12.4
N (min)	60
T (max)	18.4

Tape dimensions

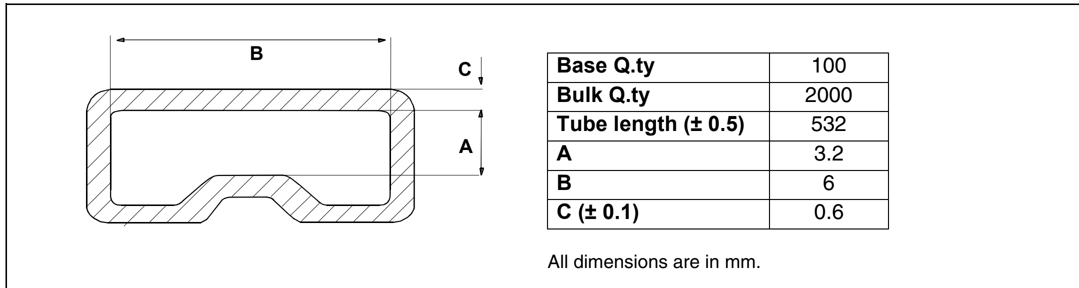
According to Electronic Industries Association (EIA) Standard 481 rev. A, Feb. 1986

Tape width	**W**	12
Tape Hole Spacing	**P0 (± 0.1)**	4
Component Spacing	**P**	8
Hole Diameter	**D (+ 0.1/-0)**	1.5
Hole Diameter	**D1 (min)**	1.5
Hole Position	**F (± 0.05)**	5.5
Compartment Depth	**K (max)**	4.5
Hole Spacing	**P1 (± 0.1)**	2

All dimensions are in mm.

5.6 SO8 packing information

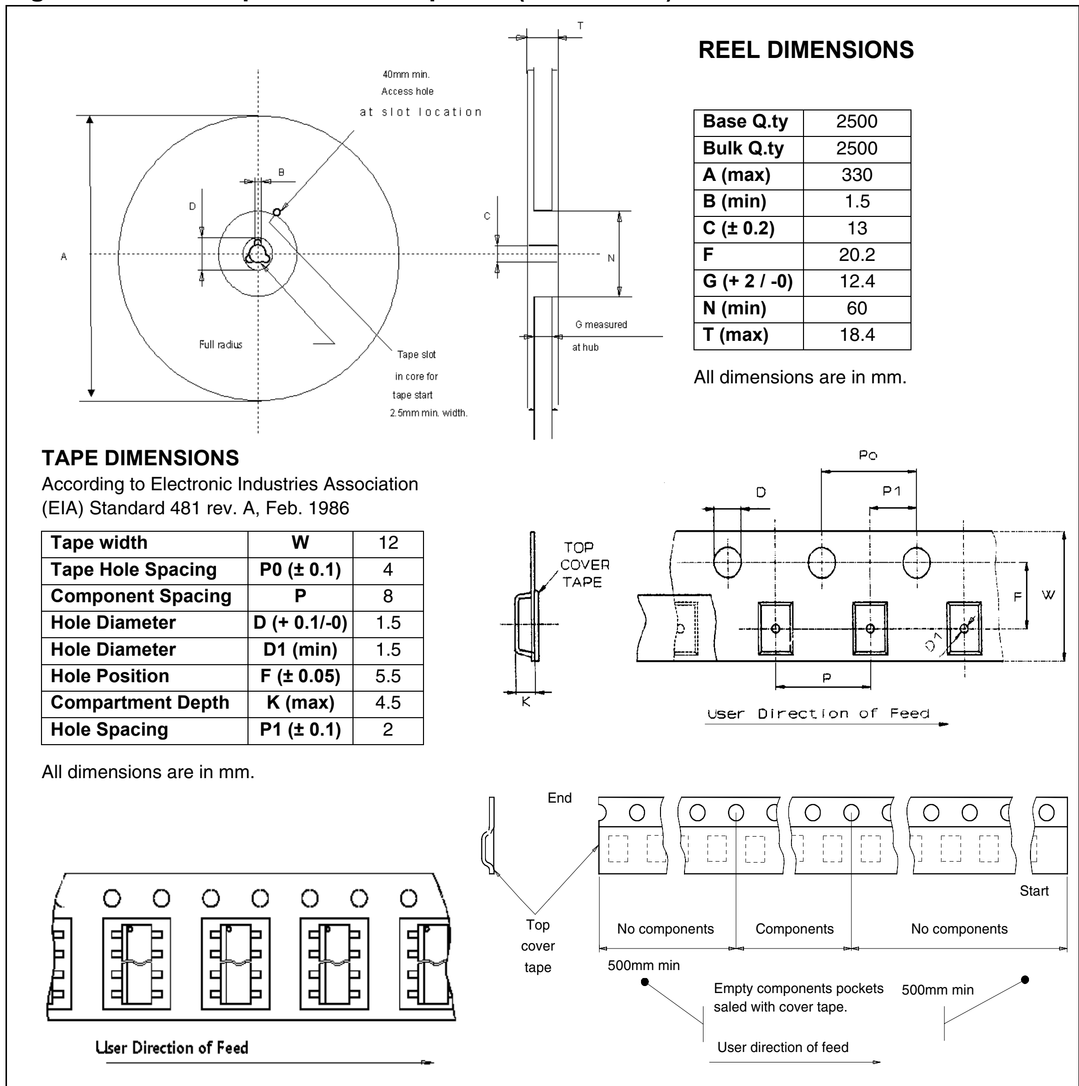
Figure 46. SO-8 tube shipment (no suffix)



Base Q.ty	100
Bulk Q.ty	2000
Tube length (± 0.5)	532
A	3.2
B	6
C (± 0.1)	0.6

All dimensions are in mm.

Figure 47. SO-8 tape and reel shipment (suffix “TR”)



REEL DIMENSIONS

Base Q.ty	2500
Bulk Q.ty	2500
A (max)	330
B (min)	1.5
C (± 0.2)	13
F	20.2
G (+ 2 / -0)	12.4
N (min)	60
T (max)	18.4

All dimensions are in mm.

TAPE DIMENSIONS

According to Electronic Industries Association (EIA) Standard 481 rev. A, Feb. 1986

Tape width	W	12
Tape Hole Spacing	P0 (± 0.1)	4
Component Spacing	P	8
Hole Diameter	D (+ 0.1/-0)	1.5
Hole Diameter	D1 (min)	1.5
Hole Position	F (± 0.05)	5.5
Compartment Depth	K (max)	4.5
Hole Spacing	P1 (± 0.1)	2

All dimensions are in mm.

6 Revision history

Table 10. Document revision history

Date	Revision	Changes
Feb-2003	1	Initial release.
16-Apr-2009	2	Added *Table 1: Device summary on page 1* and *Section 4: Package and PCB thermal data* Updated *Section 5: Package and packing information on page 25*

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